

N-Channel Super Junction Power MOSFET $\, III \,$

General Description

The series of devices use advanced trench gate super junction technology and design to provide excellent R_{DS(ON)} with low gate charge. This super junction MOSFET fits the industry's AC-DC SMPS requirements for PFC, AC/DC power conversion, and industrial power applications.

Features

- •New technology for high voltage device
- •Low on-resistance and low conduction losses
- •Small package
- ●Ultra Low Gate Charge cause lower driving requirements
- ●100% Avalanche Tested
- ●ROHS compliant

Application

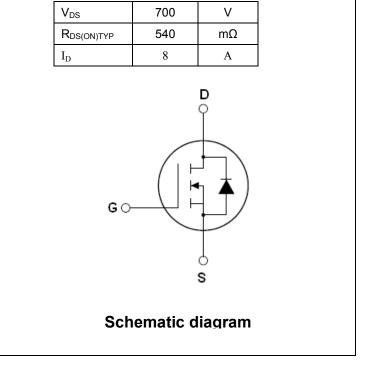
- Power factor correction (PFC)
- Switched mode power supplies(SMPS)
- Uninterruptible Power Supply (UPS)

Package Marking And Ordering Information

Device	Device Package	Marking
NCE70T540I	TO-251	NCE70T540I
NCE70T540K	TO-252	NCE70T540K

Table 1. Absolute Maximum Ratings (T_c=25℃)

Parameter	Symbol	Value	Unit
Drain-Source Voltage (VGs=0V)	Vds	700	V
Gate-Source Voltage (V _{DS=0V}) ,AC (f>1 Hz)	Vgs	±30	V
Continuous Drain Current at Tc=25°C	I _{D (DC)}	8	А
Continuous Drain Current at Tc=100°C	D (DC)	5.2	А
Pulsed drain current (Note 1)	DM (pluse)	32	А
Maximum Power Dissipation(Tc=25°C)	P _D	69	W
Derate above 25°C		0.55	W/°C
Single pulse avalanche energy (Note2)	Eas	156	mJ
Avalanche current ^(Note 1)	I _{AR}	1.7	А
Repetitive Avalanche energy , t_{AR} limited by T_{jmax} (Note 1)	E _{AR}	0.3	mJ
Parameter	Symbol	Value	Unit



TO-251

TO-252



NCE70T540I, NCE70T540K

Drain Source voltage slope, $V_{DS} \leq 480 V$,	dv/dt	50	V/ns
Reverse diode dv/dt, $V_{DS} \leqslant 480 \text{ V}, I_{SD} < I_D$	dv/dt	15	V/ns
Operating Junction and Storage Temperature Range	TJ,TSTG	-55+150	°C

Table 2. Thermal Characteristic

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case (Maximum)	R _{thJC}	1.81	°C /W
Thermal Resistance, Junction-to-Ambient (Maximum)	R _{thJA}	62	°C /W

Table 3. Electrical Characteristics (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
On/off states			•		•	
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250µA	700			V
Zero Gate Voltage Drain Current(Tc=25°C)	I _{DSS}	V _{DS} =700V,V _{GS} =0V			1	μA
Zero Gate Voltage Drain Current(Tc=125°C)	I _{DSS}	V _{DS} =700V,V _{GS} =0V			100	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V			±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =250µA	3		4	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =4A		540	600	mΩ
Dynamic Characteristics			•	•		
Input Capacitance	Clss			590		pF
Output Capacitance	C _{oss}	V _{DS} =50V,V _{GS} =0V, F=1.0MHz		37		pF
Reverse Transfer Capacitance	C _{rss}			0.9		pF
Total Gate Charge	Qg)/ _400)// _04		14.6	22	nC
Gate-Source Charge	Q _{gs}	V _{DS} =480V,I _D =8A, V _{GS} =10V		4		nC
Gate-Drain Charge	Q _{gd}	V _{GS} =10V		6.7		nC
Switching times		·				
Turn-on Delay Time	t _{d(on)}			9		nS
Turn-on Rise Time	tr	V _{DD} =420V,I _D =4A,		6.5		nS
Turn-Off Delay Time	t _{d(off)}	R _G =4.7Ω,V _{GS} =10V		61		nS
Turn-Off Fall Time	t _f			10		nS
Source- Drain Diode Characteristics				•		
Source-drain current(Body Diode)	I _{SD}	T 05°0			8	А
Pulsed Source-drain current(Body Diode)	I _{SDM}	T _C =25°C			32	А
Forward On Voltage	V _{SD}	Tj=25°C,I _{SD} =8A,V _{GS} =0V		0.9	1.2	V
Reverse Recovery Time	t _{rr}	Ω _{rr} Tj=25°C,I _F =4A,di/dt=100A/μs		230		nS
Reverse Recovery Charge	Qrr			1.2		uC
Peak Reverse Recovery Current	Irrm			10.5		А

Notes: 1.Repetitive Rating: Pulse width limited by maximum junction temperature

2. Tj=25°C,VDD=50V,VG=10V, R_G=25Ω



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (curves)

Figure1. Safe operating area

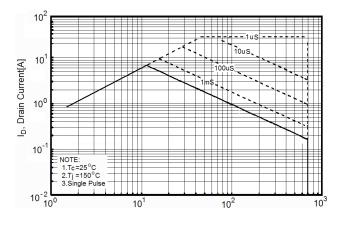


Figure3. Source-Drain Diode Forward Voltage

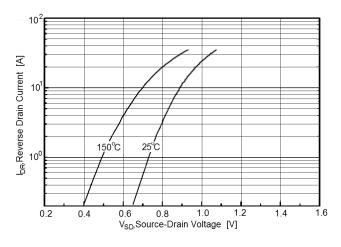
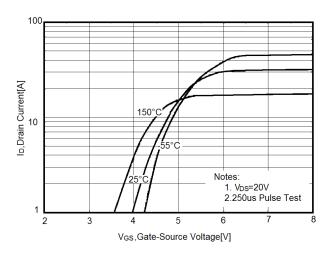


Figure 5. Transfer characteristics



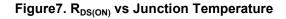


Figure2. Transient Thermal Impedance

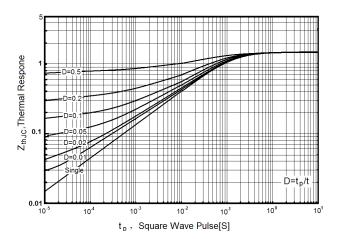


Figure4. Output characteristics

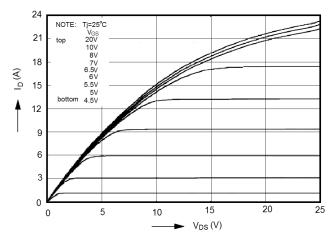


Figure6. Static drain-source on resistance

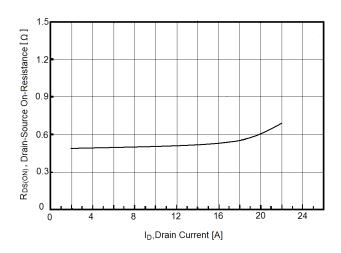
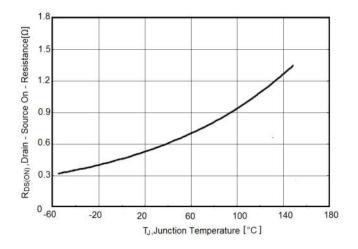


Figure8. BV_{DSS} vs Junction Temperature



NCE70T540I, NCE70T540K



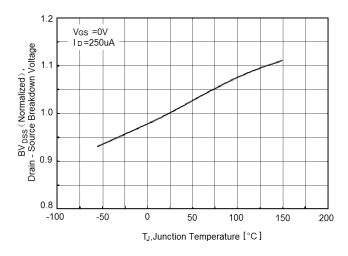


Figure9. Maximum I_D vs Junction Temperature

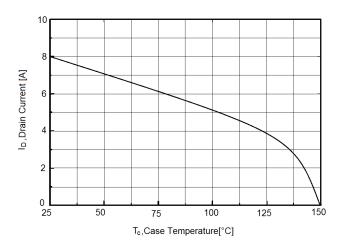


Figure11. Gate charge waveforms

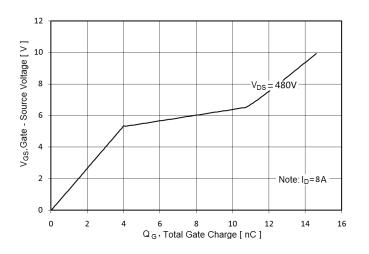
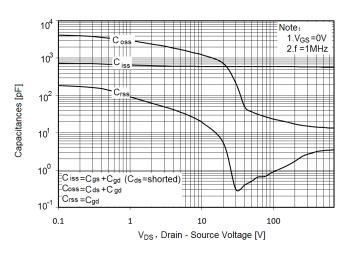


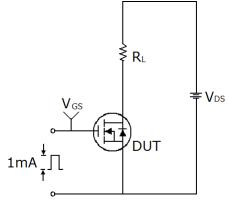
Figure10. Capacitance

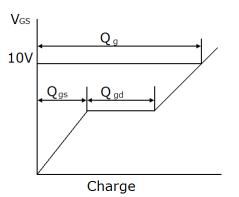




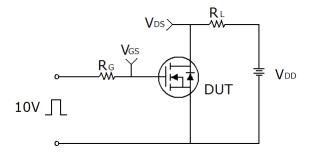
Test circuit

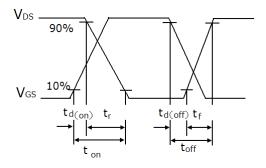
1) Gate charge test circuit & Waveform



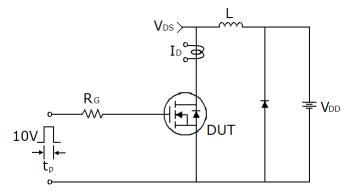


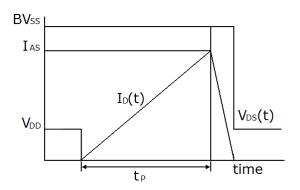
2) Switch Time Test Circuit:





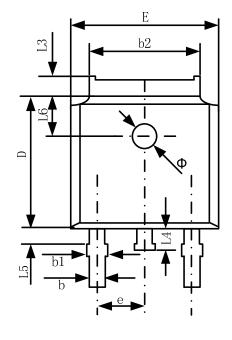
3) Unclamped Inductive Switching Test Circuit & Waveforms

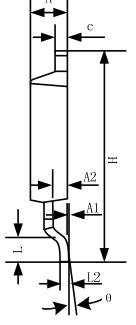


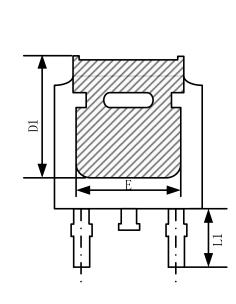




TO-252-2 Package Information



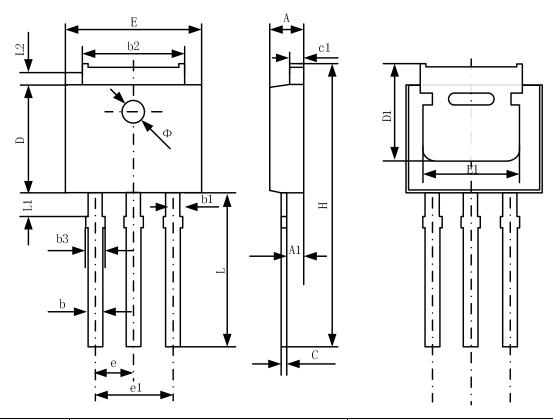




O wash a l	Dimensions	In Millimeters	Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
А	2.20	2.38	0.087	0.094	
A1	0.00	0.10	0.000	0.004	
A2	0.90	1.10	0.035	0.043	
b	0.72	0.85	0.028	0.033	
b1	0.72	0.90	0.028	0.035	
b2	5.13	5.46	0.202	0.215	
С	0.47	0.60	0.019	0.024	
D	6.00	6.20	0.236	0.244	
D1	5.25		0.207		
E	6.50	6.70	0.256	0.264	
E1	4.70		0.185		
e	2.19	2.39	0.086	0.094	
Н	9.80	10.40	0.386	0.409	
L	1.40	1.70	0.055	0.067	
L1	2.90	REF	0.114	1 REF	
L2	0.508	3 BSC	0.020) BSC	
L3	0.90	1.25	0.035	0.049	
L4	0.60	1.00	0.024	0.039	
L5	0.15	0.75	0.006	0.030	
L6	1.80 REF		0.07	1 REF	
Φ	1.20	1.40	0.047	0.055	
θ	0°	8°	0°	8°	



TO-251 Package Information



Symbol	Dimensions	In Millimeters	Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
A	2.20	2.35	0.087	0.093	
A1	0.90	1.10	0.035	0.043	
b	0.56	0.69	0.022	0.027	
b1	0.77	0.90	0.030	0.035	
b2	5.23	5.43	0.206	0.214	
b3		1.05	0.000	0.041	
С	0.46	0.59	0.018	0.023	
c1	0.46	0.59	0.018	0.023	
D	6.00	6.20	0.236	0.244	
D1	5.20		0.205		
E	6.50	6.70	0.256	0.264	
E1	4.60	5.00	0.181		
e	2.24	2.34	0.088	0.092	
e1	4.47	4.67	0.176	0.184	
Н	16.18	16.78	0.637	0.661	
L	9.00	9.60	0.354	0.378	
L1	0.95	1.35	0.037	0.053	
L2	0.90	1.25	0.035	0.049	



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